

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/714,778	ALLEN ET AL.	
Examiner	Art Unit	
Dimple N. Bodawala	1722	

SEARCHED						
Class	Subclass	Date	Examiner			
425	72.2	4/10/2007	DB			
264	211.14	4/10/2007	DB			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Updated previous search	4/10/2007	DB			
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